

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/849,197	WATANABE ET AL	
		Examiner	Art Unit	
		John S. Chu	1752	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0095527 A1	05-2005	Yokoyama et al.	430/270.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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